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**Electromagnetic compatibility - Testing and measurement
techniques - Part 36: Intentional electromagnetic interference
immunity test methods for equipment and systems**

电磁兼容 试验和测量技术 第36部分：设备和系统的有意电磁干扰抗扰度试验方法

(English Translation)

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Foreword

This document is in accordance with the provisions of GB/T 1.1-2020 "Guidelines for standardization work Part 1: Structure and drafting rules for standardization documents" Drafting.

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- GB/T 17626.3-2023 Electromagnetic compatibility test and measurement technology Part 3: Radio frequency electromagnetic field radiated immunity test;
- GB/T 17626.4-2018 Electromagnetic compatibility test and measurement technology Electrical fast transient pulse group immunity test;
- GB/T 17626.5-2019 Electromagnetic compatibility test and measurement technology surge (impact) immunity test;
- GB/T 17626.6-2017 Electromagnetic compatibility test and measurement technology Radio frequency field induced conducted disturbance immunity;
- GB/T 17626.7-2017 Electromagnetic compatibility test and measurement technology Power supply system and connected equipment harmonic and interharmonic measurement Guidelines for volume and measuring instruments;
- GB/T 17626.8-2006 Electromagnetic compatibility test and measurement technology Power frequency magnetic field immunity test;
- GB/T 17626.9-2011 Electromagnetic compatibility test and measurement technology pulse magnetic field immunity test;
- GB/T 17626.10-2017 Electromagnetic compatibility test and measurement technology Damped oscillating magnetic field immunity test;
- GB/T 17626.11-2023 Electromagnetic compatibility test and measurement technology Part 11: For each phase input current less than or equal to Voltage sag, short interruption and voltage variation immunity test for 16A equipment;
- GB/T 17626.12-2023 Electromagnetic compatibility test and measurement techniques Part 12: Ringing wave immunity test;
- GB/T 17626.13-2006 Electromagnetic compatibility test and measurement technology AC power port harmonics, interharmonics and power grid signal Low frequency immunity test of signal;
- GB/T 17626.14-2005 Electromagnetic compatibility test and measurement technology Voltage fluctuation immunity test;
- GB/T 17626.15-2011 Electromagnetic compatibility test and measurement technology Flicker meter function and design specification;
- GB/T 17626.16-2007 Electromagnetic compatibility test and measurement technology